Se	arch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/613,058	MAYER ET AL.		
Examiner	Art Unit		
Tam M. Nauven	1764		

	SEARCHED					
Class	Subclass	Date	Examiner			
208	251R					
	252					
	253					
	251H	1/20/2005	TN			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SE (INCLUDIN	EARCH NOT G SEARCH	'ES STRATEGY	)
		DATE	EXMR
EAST		1/20/2005	TN
-			